Self-Protected Low Side Driver with Temperature and Current Limit

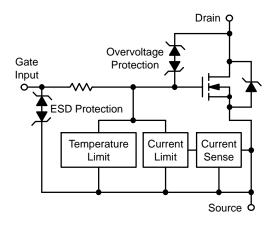
NCV8402/A is a three terminal protected Low–Side Smart Discrete device. The protection features include overcurrent, overtemperature, ESD and integrated Drain–to–Gate clamping for overvoltage protection. This device offers protection and is suitable for harsh automotive environments.

Features

- Short-Circuit Protection
- Thermal Shutdown with Automatic Restart
- Overvoltage Protection
- Integrated Clamp for Inductive Switching
- ESD Protection
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial



This document contains information on some products that are still under development. ON Semiconductor reserves the right to change or discontinue these products without notice.



ON Semiconductor®

www.onsemi.com

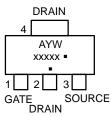
V _{(BR)DSS} (Clamped)	R _{DS(ON)} TYP	I _D MAX	
42 V	165 mΩ @ 10 V	2.0 A*	

^{*}Max current limit value is dependent on input condition.





SOT-223 CASE 318E STYLE 3





DFN6 CASE 506AX



A = Assembly Location Y = Year W or WW = Work Week xxxxx = V8402 or 8402A

xxxxx = V8402 or 8402A= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NCV8402STT1G	SOT-223	1000/Tape & Reel
NCV8402ASTT1G	(Pb-Free)	
NCV8402STT3G	SOT-223	4000/Tape & Reel
NCV8402ASTT3G	(Pb-Free)	
NCV8402AT2G (In Development)	DFN6 (Pb-Free)	3000/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

	Symbol	Value	Unit			
Drain-to-Source Voltage Intern	V _{DSS}	42	V			
Drain-to-Gate Voltage Internal	ly Clamped $(R_G = 1.0 \text{ M}\Omega)$	V_{DGR}	42	V		
Gate-to-Source Voltage		V _{GS}	±14	V		
Continuous Drain Current		I _D	Internally L	Internally Limited		
Power Dissipation	@ T _A = 25°C (Note 1) @ T _A = 25°C (Note 2) @ T _T = 25°C (Note 1)	P _D	1.1 1.7 8.9	W		
Thermal Resistance	SOT223 Junction-to-Ambient Steady State (Note 1) SOT223 Junction-to-Ambient Steady State (Note 2) SOT223 Junction-to-Tab Steady State (Note 1)	$egin{array}{l} R_{ hetaJA} \ R_{ hetaJT} \end{array}$	114 72 14	°C/W		
	DFN Junction-to-Ambient Steady State (Note 1) DFN Junction-to-Ambient Steady State (Note 2) DFN Junction-to-Tab Steady State (Note 1)	$R_{ hetaJA} \ R_{ hetaJA} \ R_{ hetaJT}$	TBD TBD TBD			
Single Pulse Drain-to-Source A (V _{DD} = 32 V, V _G = 5.0 V, I _{PK} =	E _{AS}	150	mJ			
Load Dump Voltage	(V _{GS} = 0 and 10 V, R _I = 2.0 Ω , R _L = 9.0 Ω , t _d = 400 ms)	V_{LD}	87	V		
Operating Junction Temperatur	T _J	-40 to 150	°C			
Storage Temperature	T _{stg}	-55 to 150	°C			

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface—mounted onto min pad FR4 PCB, (2 oz. Cu, 0.06" thick).

2. Surface—mounted onto 2" sq. FR4 board (1" sq., 1 oz. Cu, 0.06" thick).

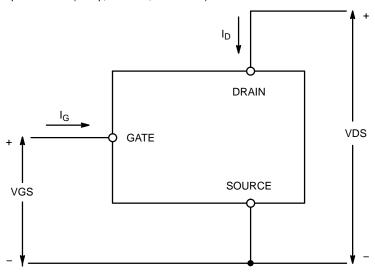


Figure 1. Voltage and Current Convention

$\textbf{ELECTRICAL CHARACTERISTICS} \; (T_J = 25^{\circ}C \; \text{unless otherwise noted})$

Parameter	1	Come !: - !	N#*	T	N/	Unit
Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage (Note 3)	$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 25^{\circ}\text{C}$	$V_{(BR)DSS}$	42	46	55	V
(Note 3)	$V_{GS} = 0 \text{ V, } I_D = 10 \text{ mA, } T_J = 150^{\circ}\text{C}$ (Note 5)		40	45	55	
Zero Gate Voltage Drain Current	$V_{GS} = 0 \text{ V}, V_{DS} = 32 \text{ V}, T_{J} = 25^{\circ}\text{C}$	I_{DSS}		0.25	4.0	μΑ
Zero Gate Voltage Drain Current	V _{GS} = 0 V, V _{DS} = 32 V, T _J = 150°C (Note 5)	I _{DSS}		1.1	20	μΑ
Gate Input Current	V _{DS} = 0 V, V _{GS} = 5.0 V	I _{GSSF}		50	100	μΑ
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 150 \mu A$	V _{GS(th)}	1.3	1.8	2.2	V
Gate Threshold Temperature Coefficient		V _{GS(th)} /T _J		4.0		-mV/°C
Static Drain-to-Source On-Resistance	V _{GS} = 10 V, I _D = 1.7 A, T _J = 25°C	R _{DS(on)}		165	200	mΩ
	V _{GS} = 10 V, I _D = 1.7 A, T _J = 150°C (Note 5)			305	400	
	V _{GS} = 5.0 V, I _D = 1.7 A, T _J = 25°C			195	230	
	V _{GS} = 5.0 V, I _D = 1.7 A, T _J = 150°C (Note 5)			360	460	
	$V_{GS} = 5.0 \text{ V}, I_D = 0.5 \text{ A}, T_J = 25^{\circ}\text{C}$			190	230	
	V _{GS} = 5.0 V, I _D = 0.5 A, T _J = 150°C (Note 5)			350	460	
Source-Drain Forward On Voltage	V _{GS} = 0 V, I _S = 7.0 A	V _{SD}		1.0		V
SWITCHING CHARACTERISTICS (Note	5)				•	•
Turn-ON Time (10% V _{IN} to 90% I _D)	V _{GS} = 10 V, V _{DD} = 12 V	t _{ON}		25		μs
Turn-OFF Time (90% V _{IN} to 10% I _D)	$I_D = 2.5 \text{ A}, R_L = 4.7 \Omega$	t _{OFF}		120		
Slew-Rate ON (70% V _{DS} to 50% V _{DS})	V _{GS} = 10 V, V _{DD} = 12 V,	-dV _{DS} /dt _{ON}		0.8		V/μs
Slew-Rate OFF (50% V _{DS} to 70% V _{DS})	$R_L = 4.7 \Omega$	dV _{DS} /dt _{OFF}		0.3		1
SELF PROTECTION CHARACTERISTIC	S (T _J = 25°C unless otherwise noted) (Note 4)				
Current Limit	$V_{DS} = 10 \text{ V}, V_{GS} = 5.0 \text{ V}, T_{J} = 25^{\circ}\text{C}$	I _{LIM}	3.7	4.3	5.0	Α
	V _{DS} = 10 V, V _{GS} = 5.0 V, T _J = 150°C (Note 5)		2.3	3.0	3.7	
	V _{DS} = 10 V, V _{GS} = 10 V, T _J = 25°C		4.2	4.8	5.4	1
	V _{DS} = 10 V, V _{GS} = 10 V, T _J = 150°C (Note 5)		2.7	3.6	4.5	
Temperature Limit (Turn-off)	V _{GS} = 5.0 V (Note 5)	T _{LIM(off)}	150	175	200	°C
Thermal Hysteresis	V _{GS} = 5.0 V	$\Delta T_{LIM(on)}$		15		1
Temperature Limit (Turn-off)	V _{GS} = 10 V (Note 5)	T _{LIM(off)}	150	165	185	1
Thermal Hysteresis	V _{GS} = 10 V	$\Delta T_{LIM(on)}$		15		1
GATE INPUT CHARACTERISTICS (Note	95)					
Device ON Gate Input Current	$V_{GS} = 5 \text{ V I}_{D} = 1.0 \text{ A}$	I _{GON}		50		μΑ
	V _{GS} = 10 V I _D = 1.0 A			400		1
Current Limit Gate Input Current	V _{GS} = 5 V, V _{DS} = 10 V	I _{GCL}		0.05		mA
	V _{GS} = 10 V, V _{DS} = 10 V			0.4		
Thermal Limit Fault Gate Input Current	V _{GS} = 5 V, V _{DS} = 10 V	I _{GTL}		0.15		mA
	V _{GS} = 10 V, V _{DS} = 10 V			0.7		7

- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
 4. Fault conditions are viewed as beyond the normal operating range of the part.
 5. Not subject to production testing.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Test Condition	Symbol	Min	Тур	Max	Unit	
ESD ELECTRICAL CHARACTERISTICS (T _J = 25°C unless otherwise noted) (Note 5)							
Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	4000			V	
	Machine Model (MM)		400				

- Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Fault conditions are viewed as beyond the normal operating range of the part.
 Not subject to production testing.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL PERFORMANCE CURVES

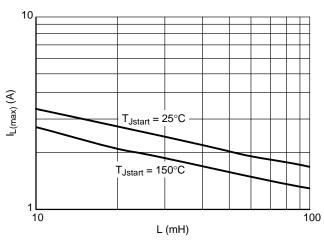


Figure 2. Single Pulse Maximum Switch-off Current vs. Load Inductance

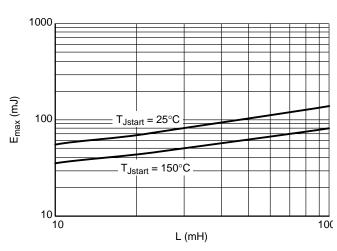


Figure 3. Single Pulse Maximum Switching Energy vs. Load Inductance

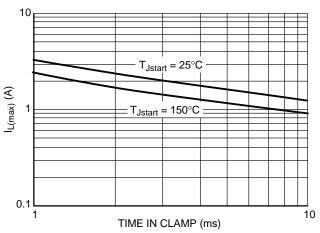


Figure 4. Single Pulse Maximum Inductive Switch-off Current vs. Time in Clamp

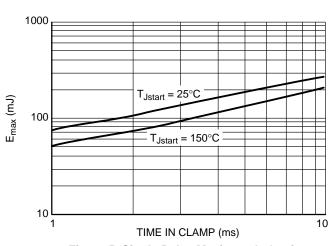


Figure 5. Single Pulse Maximum Inductive Switching Energy vs. Time in Clamp

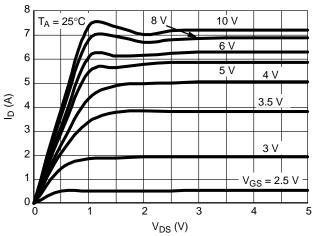


Figure 6. On-state Output Characteristics

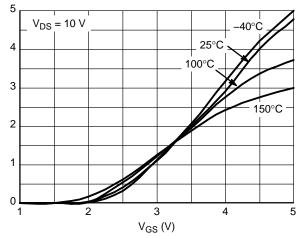


Figure 7. Transfer Characteristics

 $I_{D}(A)$

TYPICAL PERFORMANCE CURVES

I⊔M (A)

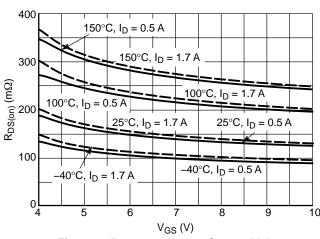


Figure 8. R_{DS(on)} vs. Gate-Source Voltage

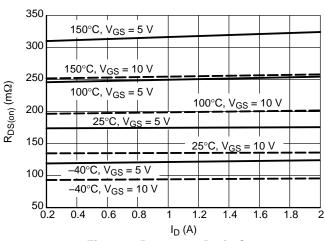


Figure 9. R_{DS(on)} vs. Drain Current

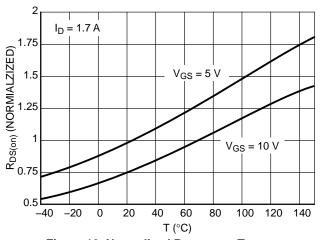


Figure 10. Normalized R_{DS(on)} vs. Temperature

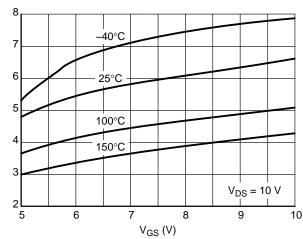


Figure 11. Current Limit vs. Gate-Source Voltage

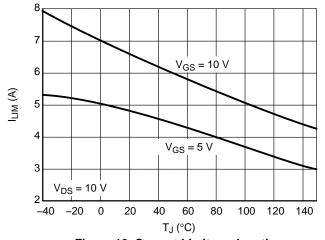


Figure 12. Current Limit vs. Junction Temperature

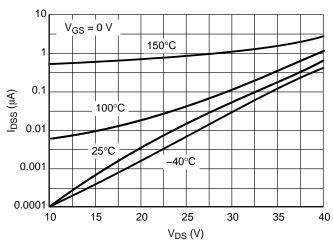


Figure 13. Drain-to-Source Leakage Current

TYPICAL PERFORMANCE CURVES

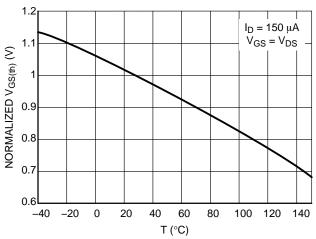


Figure 14. Normalized Threshold Voltage vs. Temperature

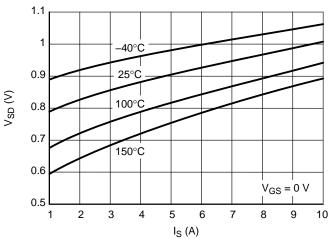


Figure 15. Source–Drain Diode Forward Characteristics

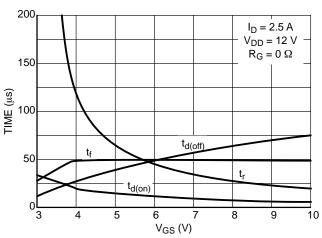


Figure 16. Resistive Load Switching Time vs.
Gate-Source Voltage

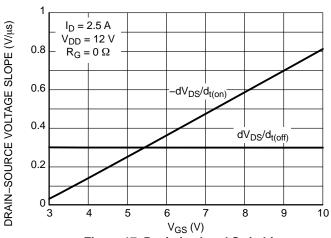


Figure 17. Resistive Load Switching
Drain-Source Voltage Slope vs. Gate-Source
Voltage

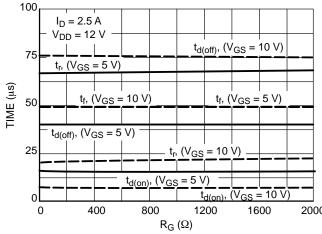


Figure 18. Resistive Load Switching Time vs.

Gate Resistance

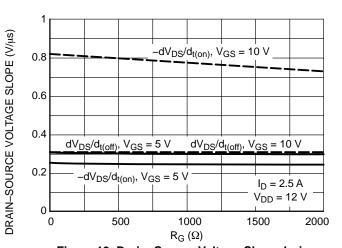


Figure 19. Drain-Source Voltage Slope during Turn On and Turn Off vs. Gate Resistance

TYPICAL PERFORMANCE CURVES

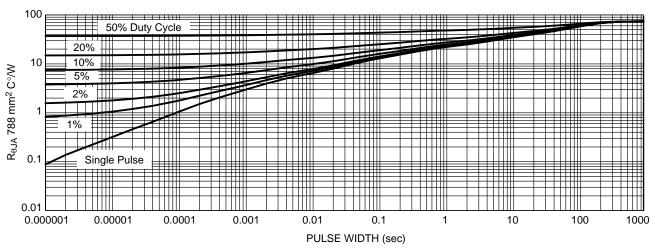


Figure 20. Transient Thermal Resistance

TEST CIRCUITS AND WAVEFORMS

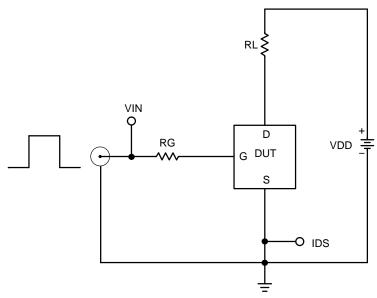


Figure 21. Resistive Load Switching Test Circuit

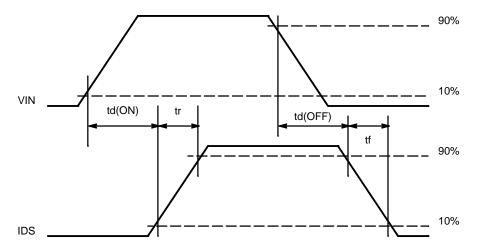


Figure 22. Resistive Load Switching Waveforms

TEST CIRCUITS AND WAVEFORMS

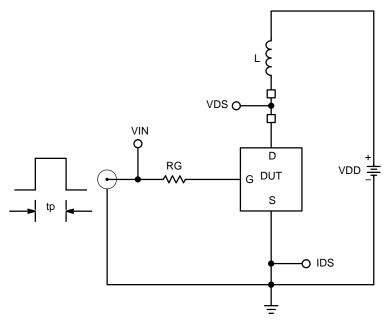


Figure 23. Inductive Load Switching Test Circuit

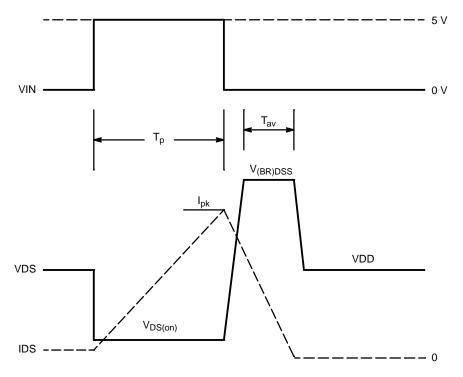
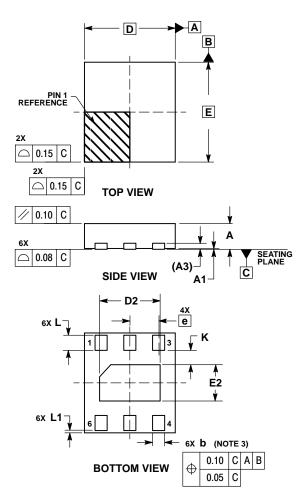


Figure 24. Inductive Load Switching Waveforms

PACKAGE DIMENSIONS

DFN6 3x3.3 MM, 0.95 PITCH CASE 506AX

ISSUE O

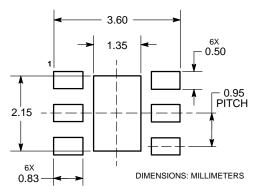


- NOTES:
 1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.
 3. DIMENSION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 mm EPOM TEPMINAI
 - FROM TERMINAL.

 COPLANARITY APPLIES TO THE EXPOSED PAD
 AS WELL AS THE TERMINALS.

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.80		0.90		
A1	0.00		0.05		
A3	C	.20 REF			
b	0.30		0.40		
D	3	.00 BSC	,;		
D2	1.90		2.10		
E	3	.30 BSC	;		
E2	1.10		1.30		
е	0	0.95 BSC			
K	0.20				
L	0.40		0.60		
L1	0.00		0.15		

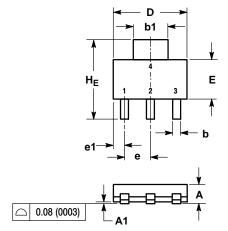
SOLDERING FOOTPRINT*

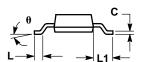


*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

SOT-223 (TO-261) CASE 318E-04 **ISSUE N**





NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: INCH.

	MILLIMETERS INCHES					
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.50	1.63	1.75	0.060	0.064	0.068
A1	0.02	0.06	0.10	0.001	0.002	0.004
b	0.60	0.75	0.89	0.024	0.030	0.035
b1	2.90	3.06	3.20	0.115	0.121	0.126
С	0.24	0.29	0.35	0.009	0.012	0.014
D	6.30	6.50	6.70	0.249	0.256	0.263
E	3.30	3.50	3.70	0.130	0.138	0.145
е	2.20	2.30	2.40	0.087	0.091	0.094
e1	0.85	0.94	1.05	0.033	0.037	0.041
L	0.20			0.008		
L1	1.50	1.75	2.00	0.060	0.069	0.078
HE	6.70	7.00	7.30	0.264	0.276	0.287
θ		_			-	

10°

0°

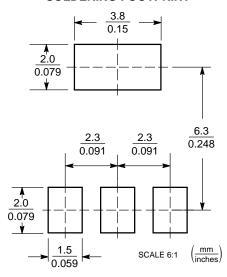
10°

STYLE 3:

PIN 1. GATE 2. DRAIN 3. SOURCE

4. DRAIN

SOLDERING FOOTPRINT



ON Semiconductor and the (III) are registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA

Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center

Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative